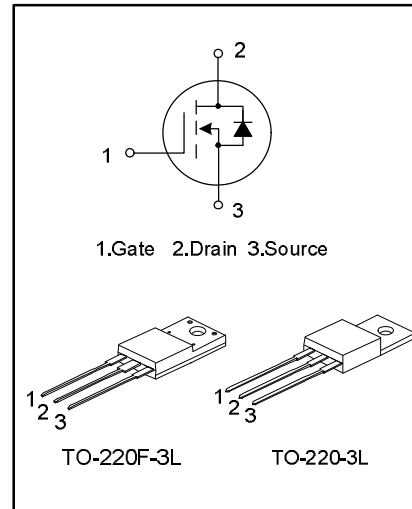


4A, 650V N-CHANNEL MOSFET

GENERAL DESCRIPTION

SVD4N65T/F is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan proprietary S-Rin™ structure DMOS technology. The improved planar stripe cell and the improved guarding ring terminal have been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are widely used in AC-DC power suppliers, DC-DC converters and H-bridge PWM motor drivers.



FEATURES

- * 4A,650V, $R_{DS(on)}$ (typ) =2.3 Ω @VGS=10V
- * Low gate charge
- * Low Crss
- * Fast switching
- * Improved dv/dt capability

ORDERING SPECIFICATIONS

| Part No. | Package | Marking | Shipping |
|----------|------------|----------|-------------|
| SVD4N65T | TO-220-3L | SVD4N65T | 50Unit/Tube |
| SVD4N65F | TO-220F-3L | SVD4N65F | 50Unit/Tube |

ABSOLUTE MAXIMUM RATINGS (Tc=25°C unless otherwise noted)

| Parameter | Symbol | SVD4N65T | SVD4N65F | Unit |
|--|------------------|----------|----------|------|
| Drain-Source Voltage | V _{DS} | 650 | | V |
| Gate-Source Voltage | V _{GS} | ±30 | | V |
| Drain Current | I _D | 4.0 | | A |
| Drain Current Pulsed | I _{DM} | 16 | | A |
| Power Dissipation(Tc=25°C) -Derate above 25°C | P _D | 100 | 33 | W |
| | | 0.8 | 0.26 | W/°C |
| Single Pulsed Avalanche Energy (Note 1) | E _{AS} | 240 | | mJ |
| Repetitive Avalanche Energy | E _{AR} | 10.6 | | mJ |
| Operation Junction Temperature | T _J | -55~+150 | | °C |
| Storage Temperature | T _{stg} | -55~+150 | | °C |

THERMAL CHARACTERISTICS

| Parameter | Symbol | SVD4N65T | SVD4N65F | Unit |
|---|------------------|----------|----------|------|
| Thermal Resistance, Junction-to-Case | R _{θJC} | 1.25 | 3.79 | °C/W |
| Thermal Resistance, Junction-to-Ambient | R _{θJA} | 62.5 | 62.5 | °C/W |

ELECTRICAL CHARACTERISTICS (T_c=25°C unless otherwise noted)

| Parameter | Symbol | Test conditions | Min. | Typ. | Max. | Unit |
|--|---------------------|--|------|------|------|------|
| Drain -Source Breakdown Voltage | BVDSS | V _{GS} =0V, I _D =250μA | 650 | -- | -- | V |
| Drain-Source Leakage Current | I _{DSS} | V _{DS} =650V, V _{GS} =0V | -- | -- | 10 | μA |
| Gate-Source Leakage Current | I _{GSS} | V _{GS} =±30V, V _{DS} =0V | -- | -- | ±100 | nA |
| Gate Threshold Voltage | V _{GS(th)} | V _{GS} = V _{DS} , I _D =250μA | 2.0 | -- | 4.0 | V |
| Static Drain- Source On State Resistance | R _{DS(on)} | V _{GS} =10V, I _D =2A | -- | 2.3 | 3.0 | Ω |
| Forward Transconductance | g _{FS} | V _{DS} = 50 V, I _D = 2 A | -- | 5.34 | -- | S |
| Input Capacitance | C _{iss} | V _{DS} =25V, V _{GS} =0V, f=1.0MHZ | -- | 556 | 710 | pF |
| Output Capacitance | C _{oss} | | -- | 50 | 80 | |
| Reverse Transfer Capacitance | C _{rss} | | -- | 3 | 11 | |
| Turn-on Delay Time | t _{d(on)} | V _{DD} =325V, I _D =4.0A, R _G =25Ω (Note 2,3) | -- | 20 | 30 | ns |
| Turn-on Rise Time | t _r | | -- | 19.3 | 80 | |
| Turn-off Delay Time | t _{d(off)} | | -- | 128 | 180 | |
| Turn-off Fall Time | t _f | | -- | 20 | 90 | |
| Total Gate Charge | Q _g | V _{DS} =520V, I _D =4.0A, V _{GS} =10V (Note 2,3) | -- | 15.8 | 20 | nC |
| Gate-Source Charge | Q _{gs} | | -- | 3.5 | -- | |
| Gate-Drain Charge | Q _{gd} | | -- | 5.6 | -- | |

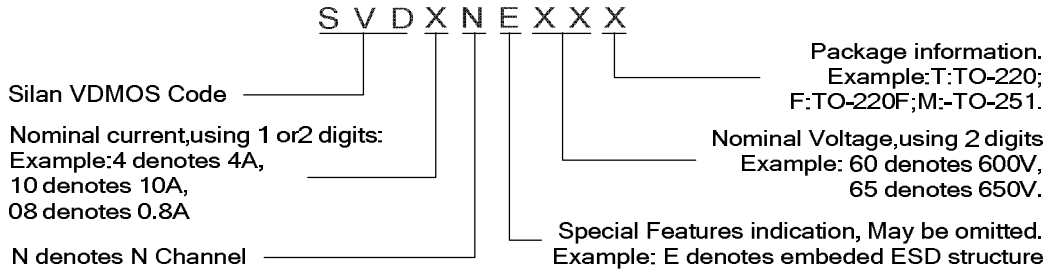
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

| Parameter | Symbol | Test conditions | Min. | Typ. | Max. | Unit |
|---------------------------|-----------------|---|------|------|------|------|
| Continuous Source Current | I _S | Integral Reverse P-N Junction Diode in the MOSFET | -- | -- | 4.0 | A |
| Pulsed Source Current | I _{SM} | | -- | -- | 16 | |
| Diode Forward Voltage | V _{SD} | I _S =4.0A, V _{GS} =0V | -- | -- | 1.4 | V |
| Reverse Recovery Time | T _{rr} | I _S =4.0A, V _{GS} =0V, dI _F /dt=100A/μs | -- | 300 | -- | ns |
| Reverse Recovery Charge | Q _{rr} | | -- | 2.2 | -- | μC |

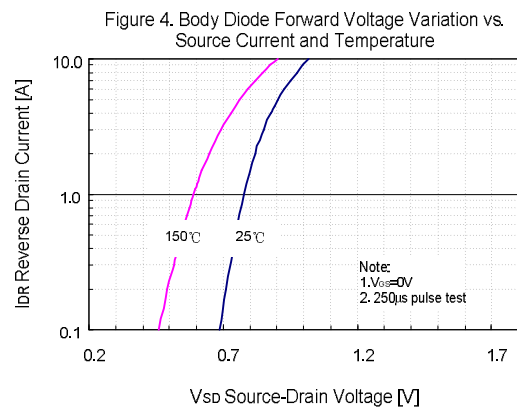
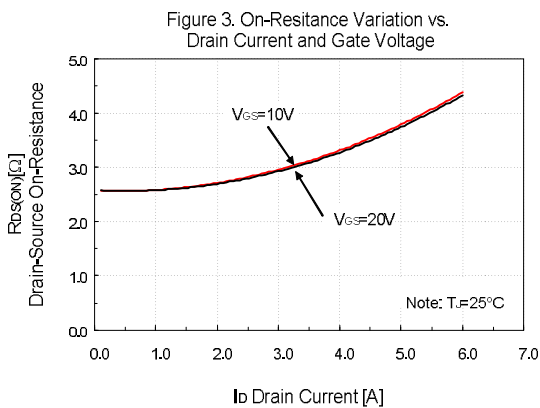
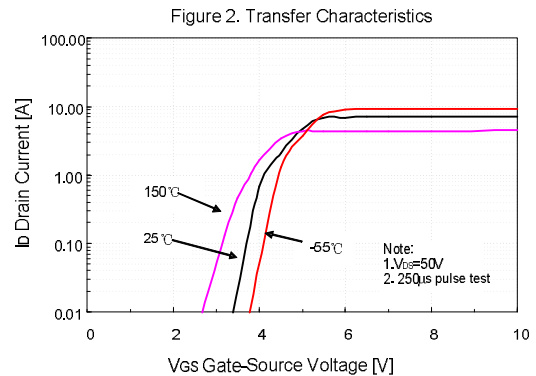
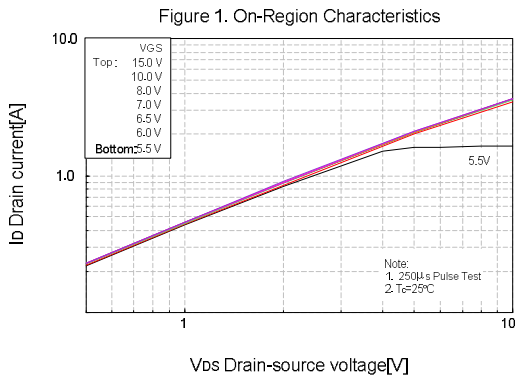
Notes:

- L=27.5mH, I_{AS}=4.0A, V_{DD}=50V, R_G=25Ω, starting T_J=25°C;
- Pulse Test: Pulse width ≤300μs, Duty cycle ≤2%;
- Essentially independent of operating temperature.

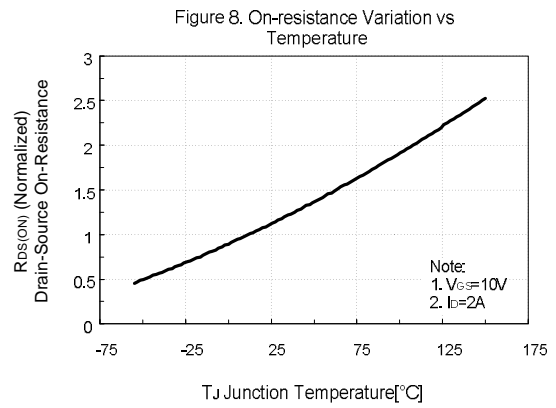
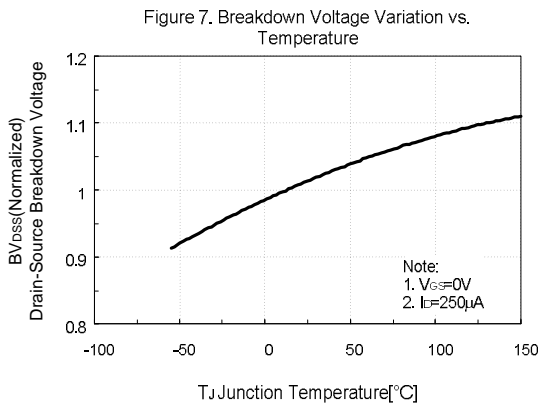
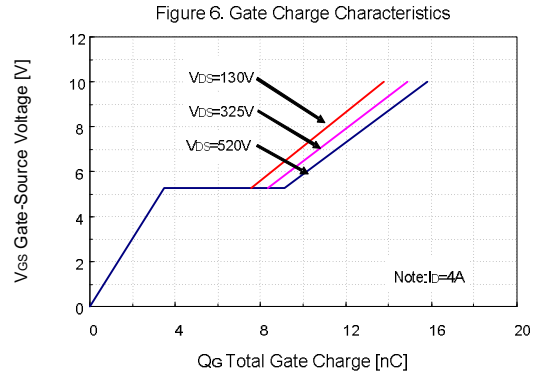
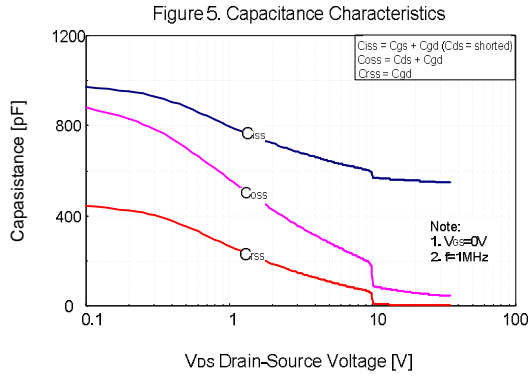
NOMENCLATURE



TYPICAL CHARACTERISTICS

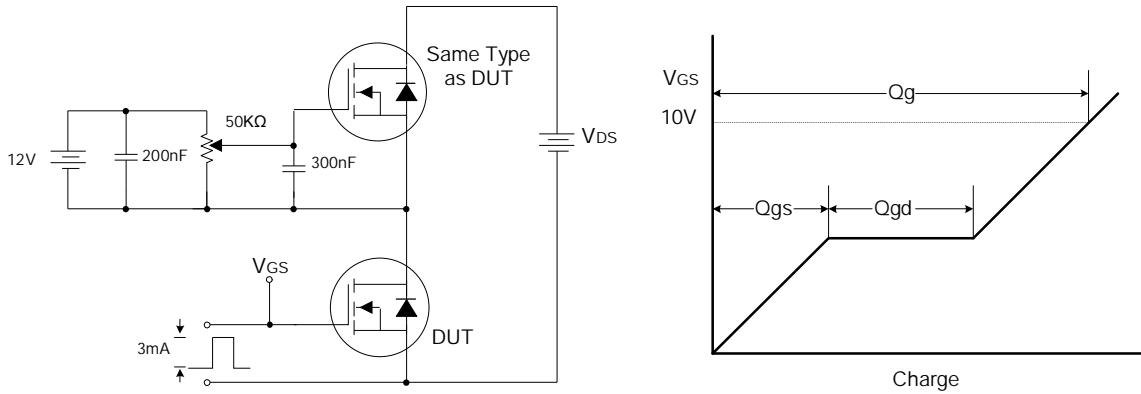


TYPICAL CHARACTERISTICS (continued)

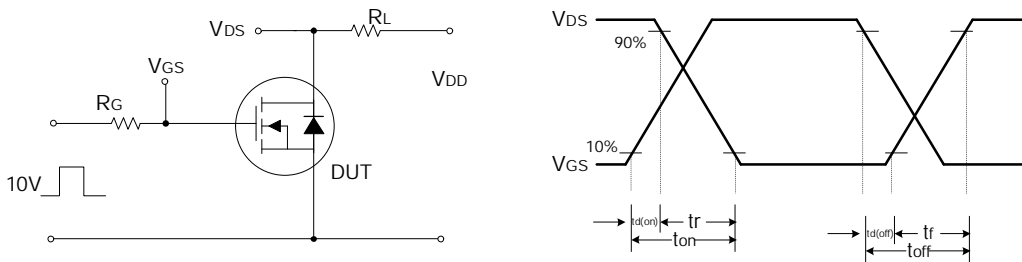


TYPICAL TEST CIRCUIT

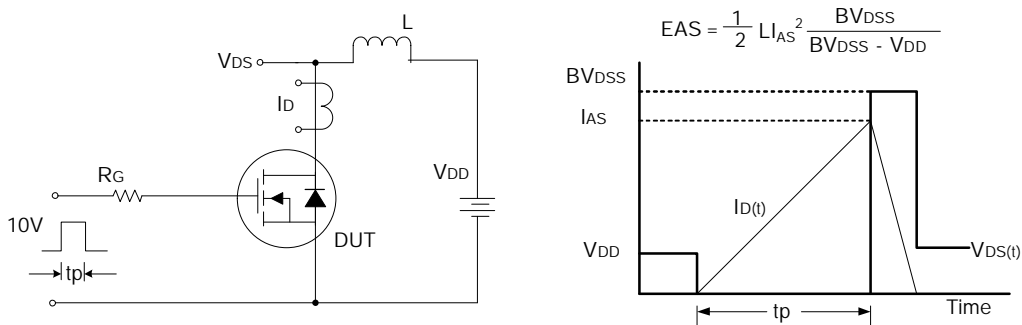
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform



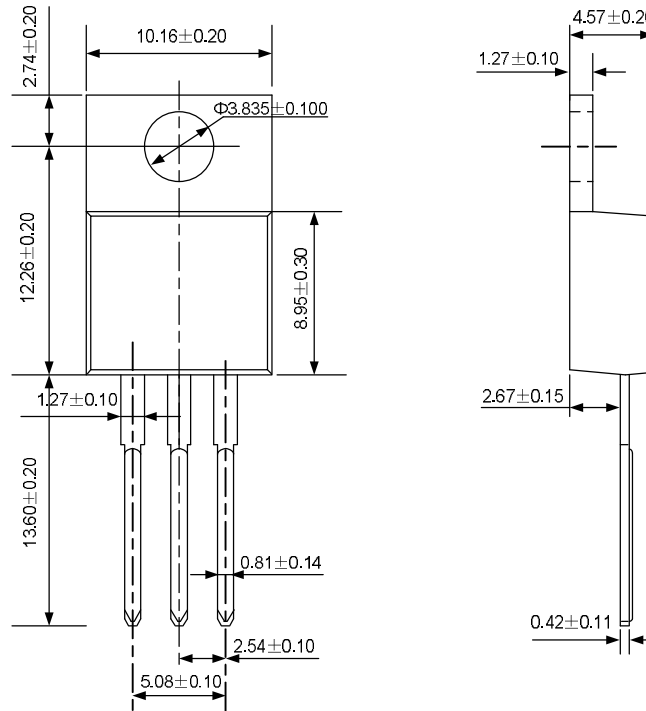
Unclamped Inductive Switching Test Circuit & Waveform



PACKAGE OUTLINE

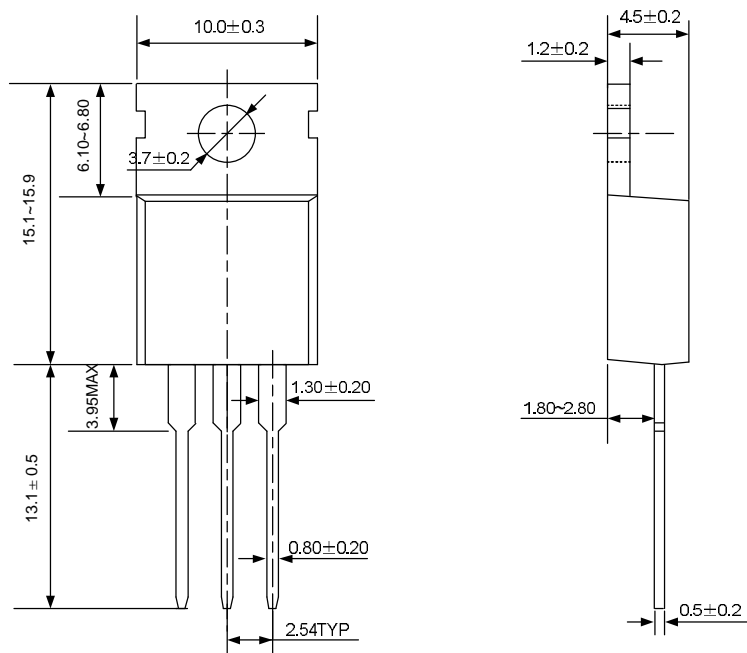
TO-220-3L(One)

UNIT: mm



TO-220-3L (Two)

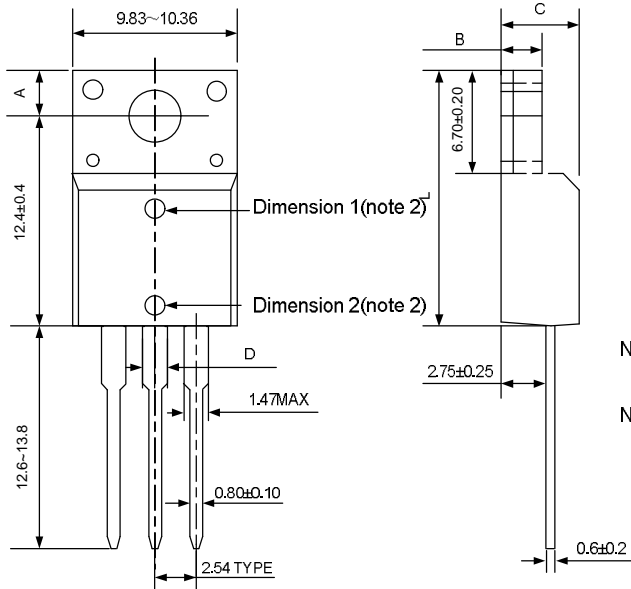
UNIT: mm



PACKAGE OUTLINE (continued)

TO-220F-3L(One)

UNIT: mm



| Symbol(note1) | Dimension1 | Dimension2 |
|---------------|------------|------------|
| A | 3.30±0.15 | 2.70±0.15 |
| B | 2.55±0.20 | 3.0±0.20 |
| C | 4.72±0.2 | 4.50±0.20 |
| D | 1.47MAX | 1.75MAX |
| L | 15.75±0.30 | 15.00±0.30 |

Note1: There may be two values for some products due to different plastic mould machine, so two dimensions of the same position are listed;

Note2: When the product size is Dimension1, the thimble hole is on top of the surface; when the size is Dimension2, the center hole is on bottom of the surface.

TO-220F-3L (Two)

UNIT: mm

